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January 2016

FDMD8240LET40

Dual N-Channel Power Trench® MOSFET 40 V, 103 A, 2.6 m Ω

Features

- Extended T_J Rating to 175 °C
- Max $r_{DS(on)}$ = 2.6 m Ω at V_{GS} = 10 V, I_D = 23 A
- Max $r_{DS(on)}$ = 3.95 m Ω at V_{GS} = 4.5 V, I_D = 19 A
- Ideal for Flexible Layout in Primary Side of Bridge Topology
- 100% UIL Tested
- Kelvin High Side MOSFET Drive Pin-out Capability
- Termination is Lead-free and RoHS Compliant

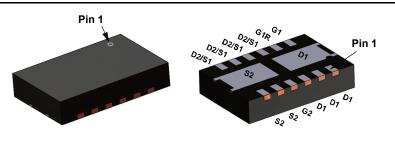


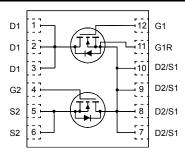
General Description

This device includes two 40V N-Channel MOSFETs in a dual Power (3.3 mm X 5 mm) package. HS source and LS Drain are internally connected for half/full bridge, low source inductance package, low $r_{DS(on)}/Qg$ FOM silicon.

Applications

- Synchronous Buck : Primary Switch of Half / Full Bridge Converter for Telecom
- Motor Bridge: Primary Switch of Half / Full bridge Converter for BLDC Motor
- MV POL : Synchronous Buck Switch





Power 3.3 x 5

MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted.

Symbol	Parame	ter		Ratings	Units
V_{DS}	Drain to Source Voltage			40	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T _C = 25 °C	(Note 5)	103	
	-Continuous	T _C = 100 °C	(Note 5)	73	A
ID	-Continuous	T _A = 25 °C	(Note 1a)	24	^
	-Pulsed		(Note 4)	489	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	216	mJ
В	Power Dissipation	T _C = 25 °C		50	w
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperat	ure Range		-55 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	60	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8240LT	FDMD8240LET40	Power 3.3 x 5	13 "	12 mm	3000 units

Units

Max.

Electrical Characteristics T_J = 25 $^{\circ}$ C unless otherwise noted.

Parameter

Off Characteristics										
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V				
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		23		mV/°C				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V			1	μΑ				
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA				

Test Conditions

On Characteristics

Symbol

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	2.0	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		-6		mV/°C
r _{DS(on)}		V _{GS} = 10 V, I _D = 23 A		2.0	2.6	
	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 19 \text{ A}$		3.2	3.95	mΩ
, ,		$V_{GS} = 10 \text{ V}, I_D = 23 \text{ A}, T_J = 150 ^{\circ}\text{C}$		3.3	4.3	
9 _{FS}	Forward Transconductance	V _{DD} = 5 V, I _D = 23 A		107		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V f = 1 MHz		3020	4230	pF
Coss	Output Capacitance			876	1230	pF
C _{rss}	Reverse Transfer Capacitance			33	52	pF
R_q	Gate Resistance		0.1	2.8	6	Ω

Switching Characteristics

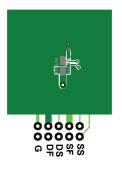
$t_{d(on)}$	Turn-On Delay Time			12	22	ns
t _r	Rise Time	$V_{DD} = 20 \text{ V}, I_D = 23$	3 A	8	16	ns
$t_{d(off)}$	Turn-Off Delay Time	$V_{\rm GS}$ = 10 V, $R_{\rm GEN}$ = 6 Ω	36	58	ns	
t _f	Fall Time			9	18	ns
0	Total Gate Charge	V _{GS} = 0 V to 10 V		40	56	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 V to 5 V$	V _{DD} = 20 V	21	30	nC
Q_{gs}	Gate to Source Charge		I _D = 23 A	9		nC
Q_{gd}	Gate to Drain "Miller" Charge	1		5		nC

Drain-Source Diode Characteristics

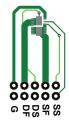
V	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 23 \text{ A}$ (Note 2)	8.0	1.3	V
V_{SD}	Source to Drain Diode i ofward voltage	$V_{GS} = 0 \text{ V}, I_S = 1.6 \text{ A}$ (Note 2)	0.7	1.2	
t _{rr}	Reverse Recovery Time	I _E = 23 A. di/dt = 100 A/μs	41	65	ns
Q _{rr}	Reverse Recovery Charge	iF - 25 A, αιναί - 100 Ανμs	21	32	nC

NOTES

^{1.} R_{0,1A} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1C} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 130 °C/W when mounted on a minimum pad of 2 oz copper

^{2.} Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.

^{3.} E_{AS} of 216 mJ is based on starting T_J = 25 o C, L = 3 mH, I_{AS} = 12 A, V_{DD} = 40 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 37 A.

^{4.} Pulsed Id please refer to Fig 11 SOA graph for more details.

^{5.} Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics T_J = 25 °C unless otherwise noted.

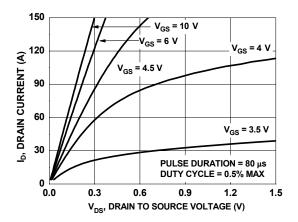


Figure 1. On-Region Characteristics

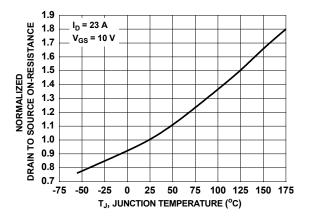


Figure 3. Normalized On Resistance vs. Junction Temperature

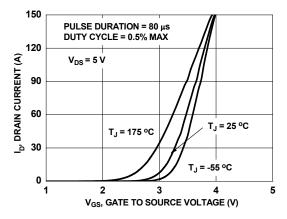


Figure 5. Transfer Characteristics

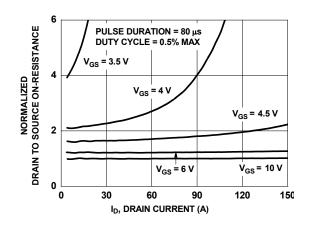


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

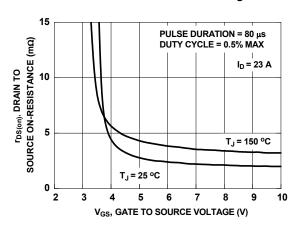


Figure 4. On Resistance vs. Gate to Source Voltage

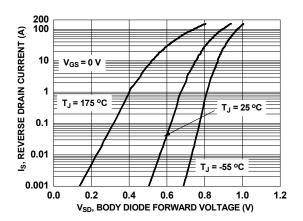


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

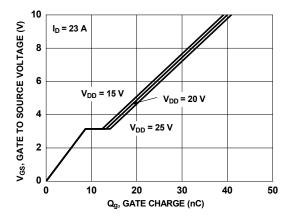


Figure 7. Gate Charge Characteristics

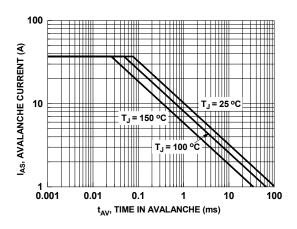


Figure 9. Unclamped Inductive Switching Capability

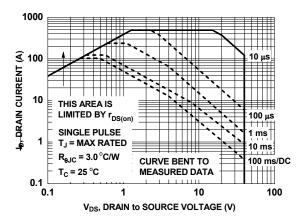


Figure 11. Forward Bias Safe Operating Area

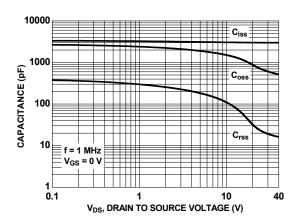


Figure 8. Capacitance vs. Drain to Source Voltage

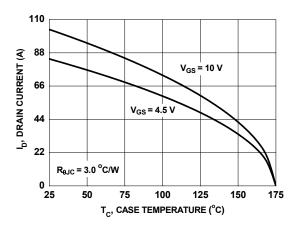


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

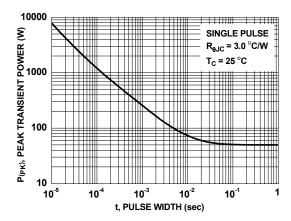


Figure 12. Single Pulse Maximum Power Dissipation



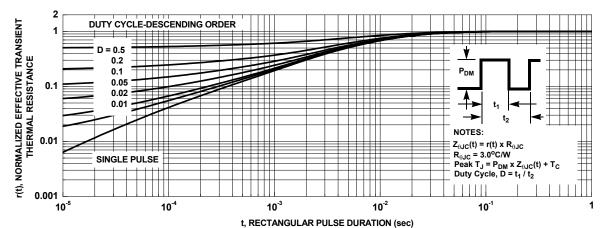
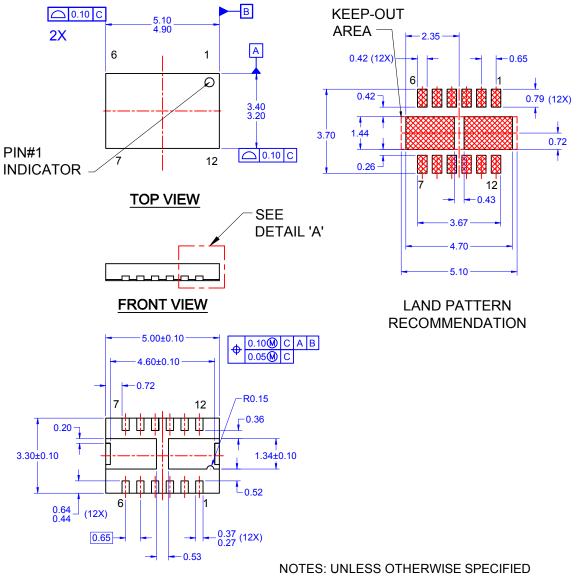


Figure 13. Junction-to-Case Transient Thermal Response Curve



BOTTOM VIEW

0.80 0.70

| 0.10 | C | E |
| 0.25 | 0.05 | SEATING
| DETAIL 'A' | SCALE: 2:1

- A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229 DATED 8/2012
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: MKT-PQFN12BREV1

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